

1 of 3

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DEPARTMENT OF COMMERCE  
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Amel C. Lavarias

9/30/05

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FORM PTO-1449 (Modified)	U.S. DEPARTMENT OF COMMERCE AND TRADEMARK OFFICE	ATTY. DOCKET NO. 714-001.27	SERIAL NO. 10/661,234
INFORMATION DISCLOSURE STATEMENT BY APPLICANT		APPLICANT John Moon, et al	
(Use several sheets if necessary) (37 CFR 1.98(b))		FILING DATE 09/12/2003	GROUP 2872

## U.S. PATENT DOCUMENTS

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EXAMINER <i>Amel C. Luvias</i>	DATE CONSIDERED <i>8/30/05</i>
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Application Number	10/661,234
Filing Date	September 12, 2003
First Named Inventor	Moon, John
Group Art Unit	2828
Examiner Name	Arnel C. Lavarias

Sheet 1 of 1

Attorney Docket No: CV-0038A US

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